# 09/462435

## 430 Rec'd PCT/PTO 0 7 JAN 2000

[113.1004]

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors:

Title:

WAVE FIELD MICROSCOPE, METHOD FOR A WAVE FIELD MICROSCOPE, INCLUDING FOR DNA SEQUENCING, AND CALIBRATION METHOD FOR WAVE FIELD MICROSCOPY

Herewith, National Phase of WO 00/0207

Filing Date:

Art Unit: Not vet known

Not yet known Examiner:

Assistant Commissioner for Patents

Washington, D.C. 20231

Dear Sir:

#### PRELIMINARY AMENDMENT

Please amend the above-identified application before a first office action on the merits as follows:

### IN THE SPECIFICATION

On page 1, before line 1, change "Specification" to -- BACKGROUND OF THE INVENTION ---.

On page 1, line 2, change "system, which includes at least one" to -system.

On page 1, delete lines 3-17.

On page 4, line 31, insert - which is not necessarily prior art to the present

application -- after "method." ai

On page 15, before line 15, insert -- SUMMARY OF THE INVENTION--.

On page 27, before line 26, insert -- DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS --.